
Computational Microelectronics L2

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Binary adder

Addition of binary numbers

- We can recognize that
 - Addition of two 1-bit binary numbers is the core operation.
 - There are only *four* possible cases.

$$0 + 0 = 0$$

$$0 + 1 = 1$$

$$1 + 0 = 1$$

$$1 + 1 = 10$$



Carry

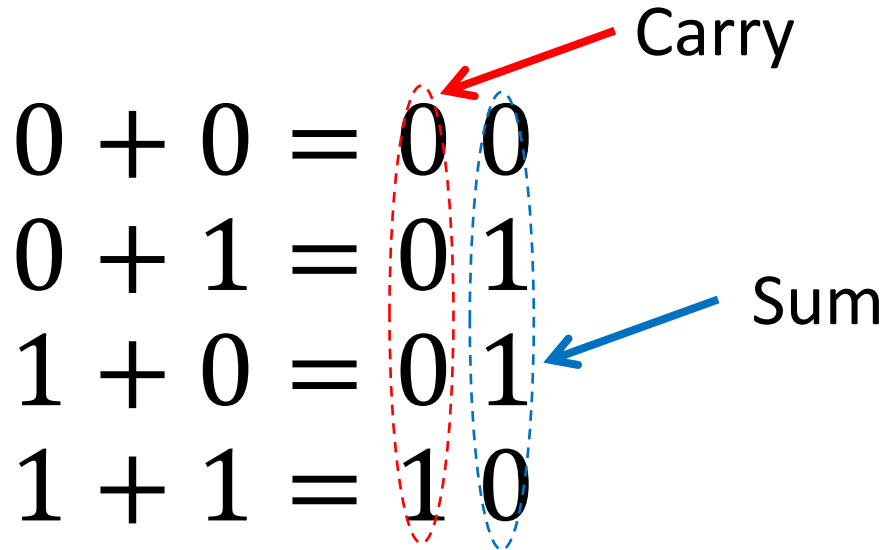
Inclusion of carry-bit

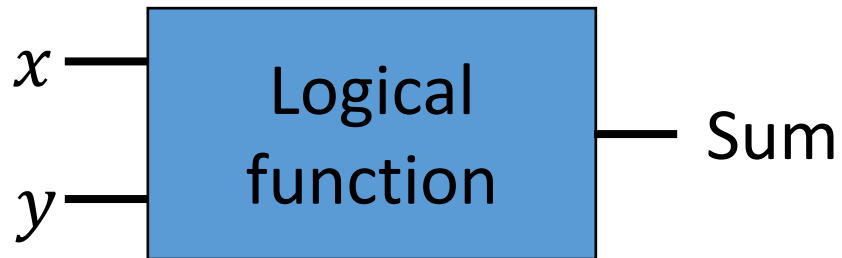
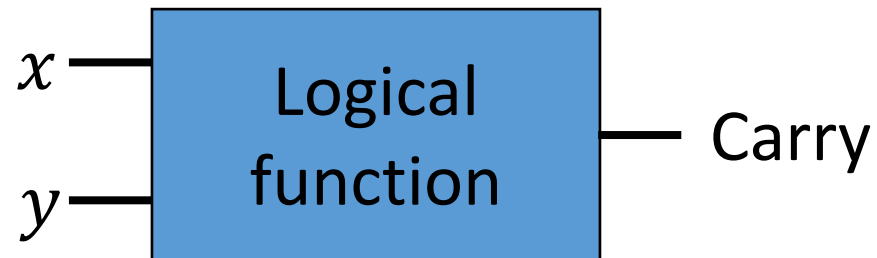
- We introduce a separate bit for representing the carry.
 - Carry-bit & sum-bit

$$\begin{array}{rcl} 0 + 0 & = & 0\ 0 \\ 0 + 1 & = & 0\ 1 \\ 1 + 0 & = & 0\ 1 \\ 1 + 1 & = & 1\ 0 \end{array}$$

Carry

Sum





Truth tables

- Relation between x , y , and the output

– Sum-bit

$x \text{ XOR } y$

x	y	sum
0	0	0
0	1	1
1	0	1
1	1	0

– Carry-bit

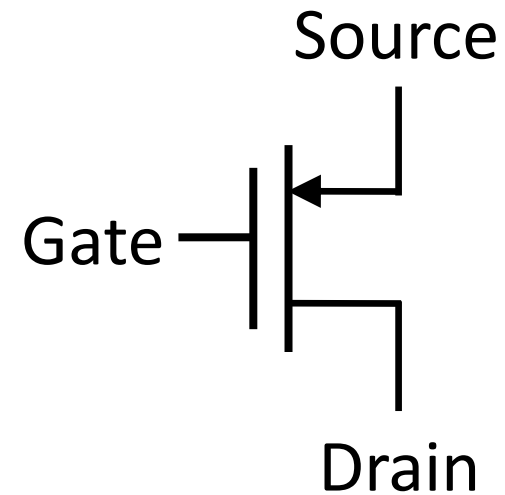
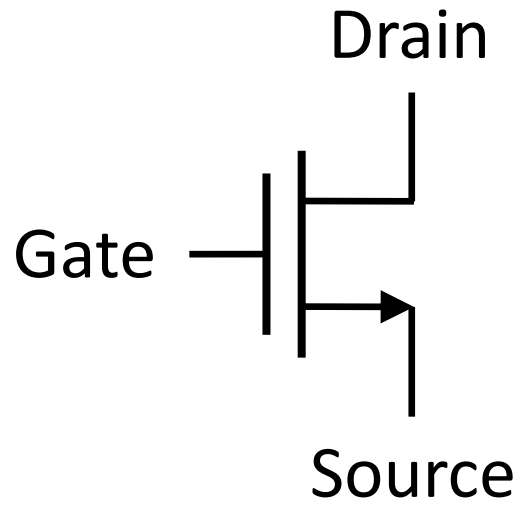
$x \text{ AND } y$

x	y	carry
0	0	0
0	1	0
1	0	0
1	1	1

Compact MOSFET model

MOSFET

- Basic unit of microelectronics
 - Controlled by the gate voltage
 - NMOSFET and PMOSFET



Level 1 model (NMOSFET)

- A simple model (Shichman-Hodges)

- Its basic current model is:

- Cutoff region, $V_{gs} < V_t$

$$I_d = 0$$

- Linear region, $V_{ds} < V_{gs} - V_t$

$$I_d = \textcolor{red}{KP} \frac{W_{eff}}{L_{eff}} (1 + \textcolor{red}{LAMBDA} \times V_{ds}) \left(V_{gs} - V_t - \frac{V_{ds}}{2} \right) V_{ds}$$

- Saturation region, $V_{ds} > V_{gs} - V_t$

$$I_d = \frac{\textcolor{red}{KP}}{2} \frac{W_{eff}}{L_{eff}} (1 + \textcolor{red}{LAMBDA} \times V_{ds}) (V_{gs} - V_t)^2$$

- (Red-colored quantities are the SPICE model parameters.)

Level 1 model (NMOSFET)

- A simple model (Shichman-Hodges)

- Threshold voltage:

- For nonnegative V_{sb} ,

$$V_t = VTO + GAMMA \left(\sqrt{PHI + V_{sb}} - \sqrt{PHI} \right)$$

- VTO is the “zero-bias” threshold voltage.

- $GAMMA$ is the body effect coefficient.

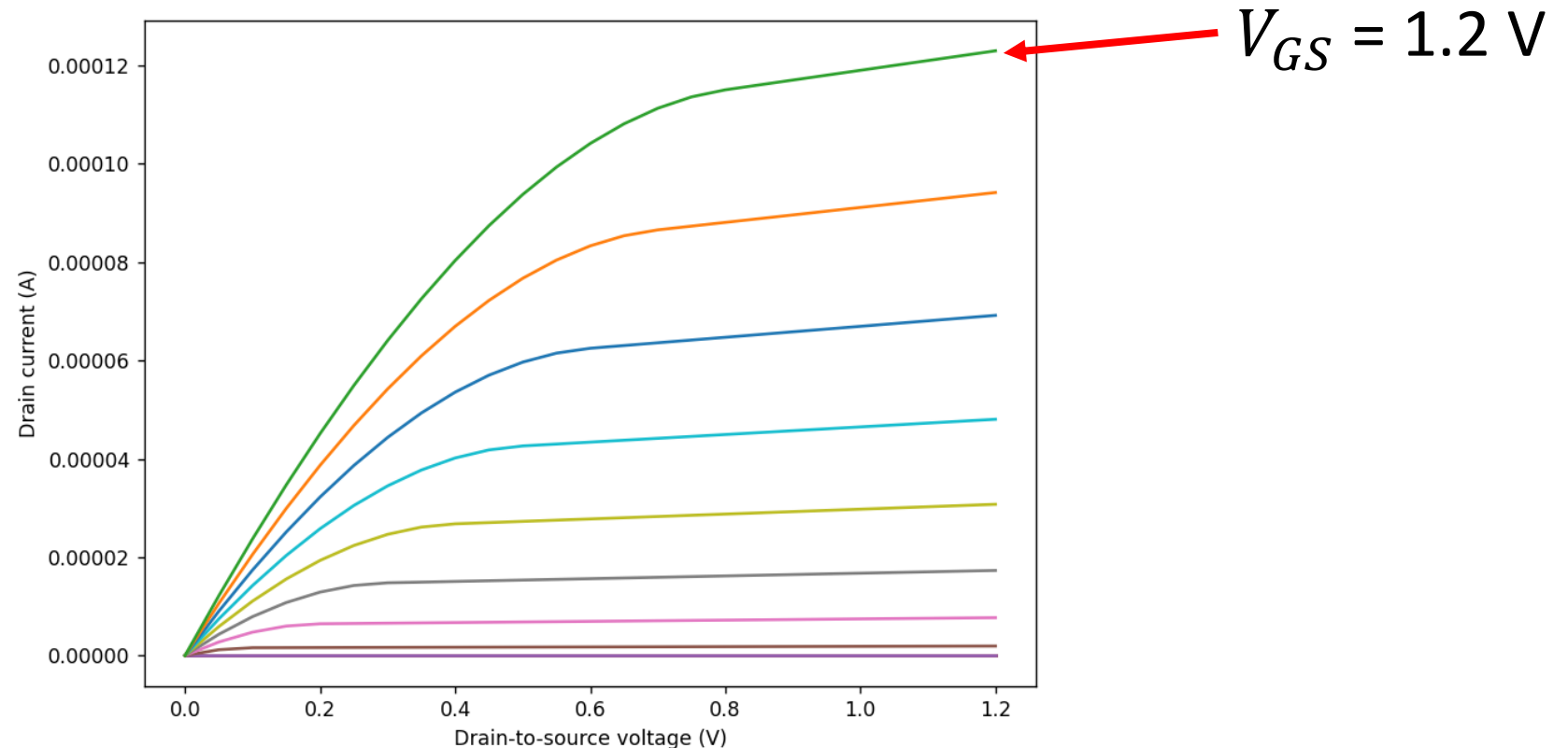
- PHI is the surface potential.

NMOSFET example

- Consider the following parameters:

$KP=155e-6$ $LAMBDA=0.2$ $VTO=0.4$ $PHI=0.93$ $GAMMA=0.6$

$$-W_{eff}/L_{eff} = 2$$

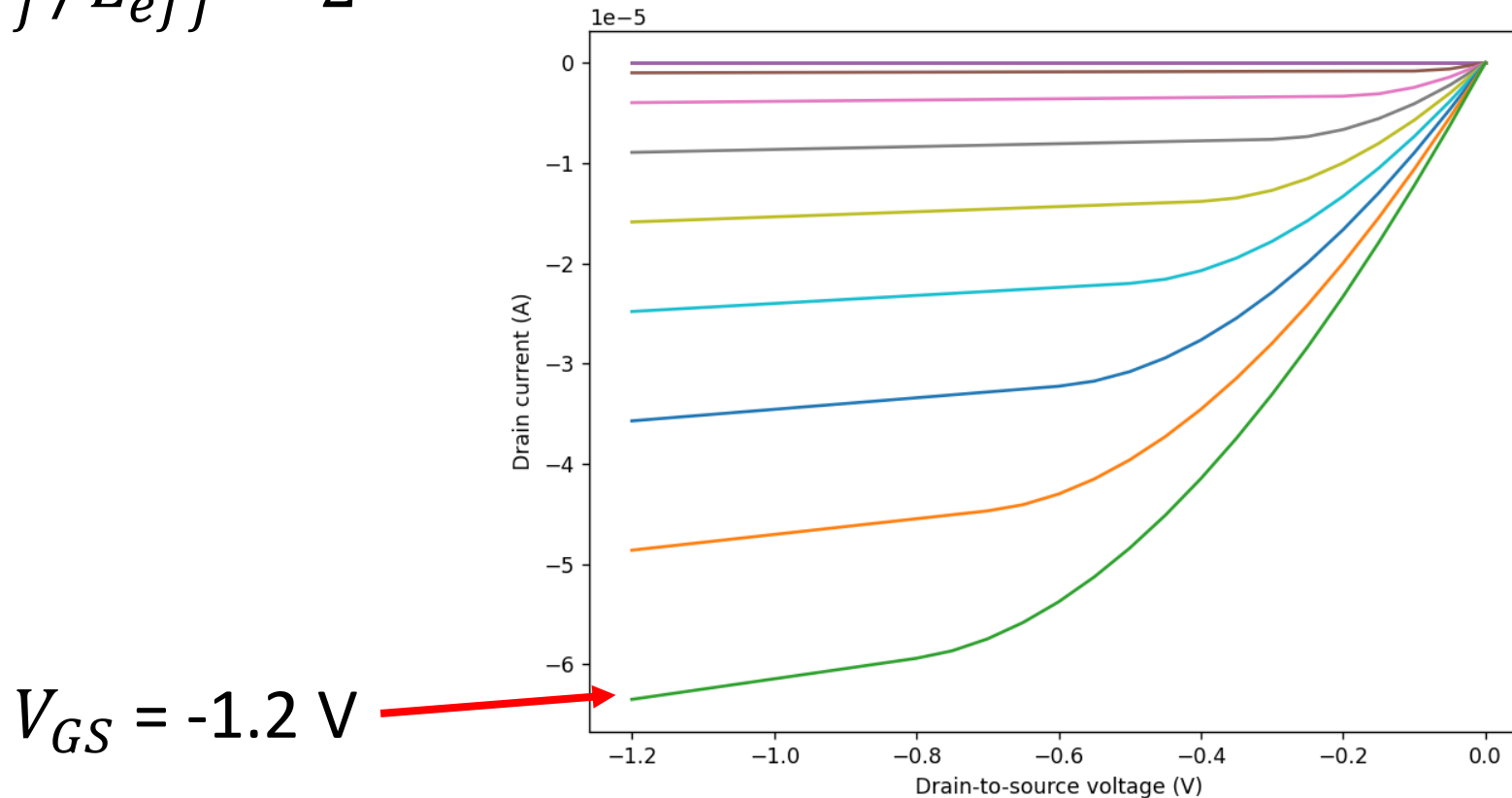


PMOSFET example

- Consider the following parameters:

$KP=80e-6$ $LAMBDA=0.2$ $VTO=-0.4$ $PHI=0.93$ $GAMMA=0.6$

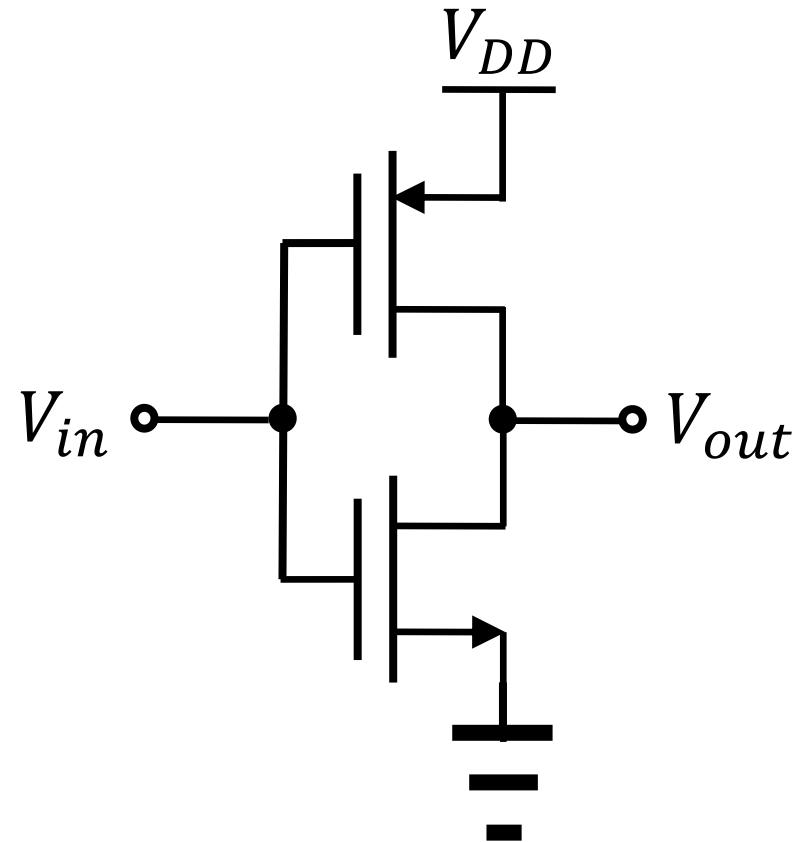
$$-W_{eff}/L_{eff} = 2$$



CMOS inverter

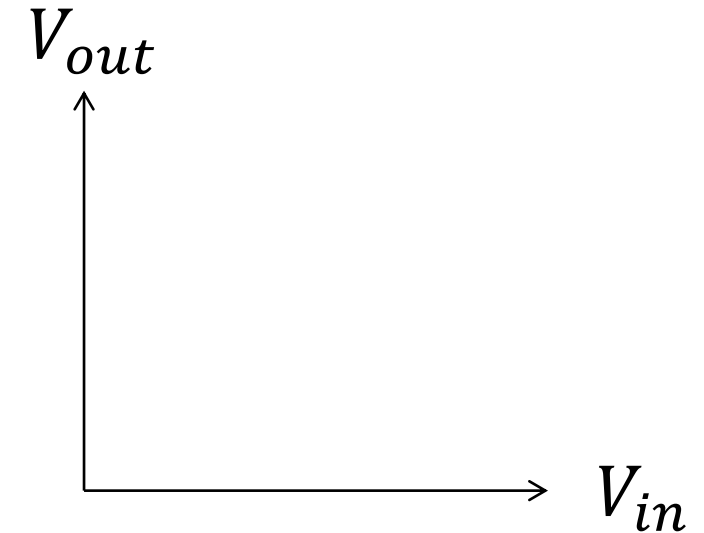
The simplest logic gate

- When $V_{in} = 0$,
 - NMOS OFF
 - PMOS ON
 - V_{out} is “pulled up.”
 - $V_{out} = V_{DD}$
- When $V_{in} = V_{DD}$,
 - NMOS ON
 - PMOS OFF
 - V_{out} is “pulled down.”
 - $V_{out} = 0$



Assume that V_{in} is given.

- The goal is to calculate V_{out} .
 - $V_{out}(V_{in})$ is called the voltage transfer curve.



- What is the condition for a point on the VTC?

$$I_{Dn} + I_{Dp} = 0$$

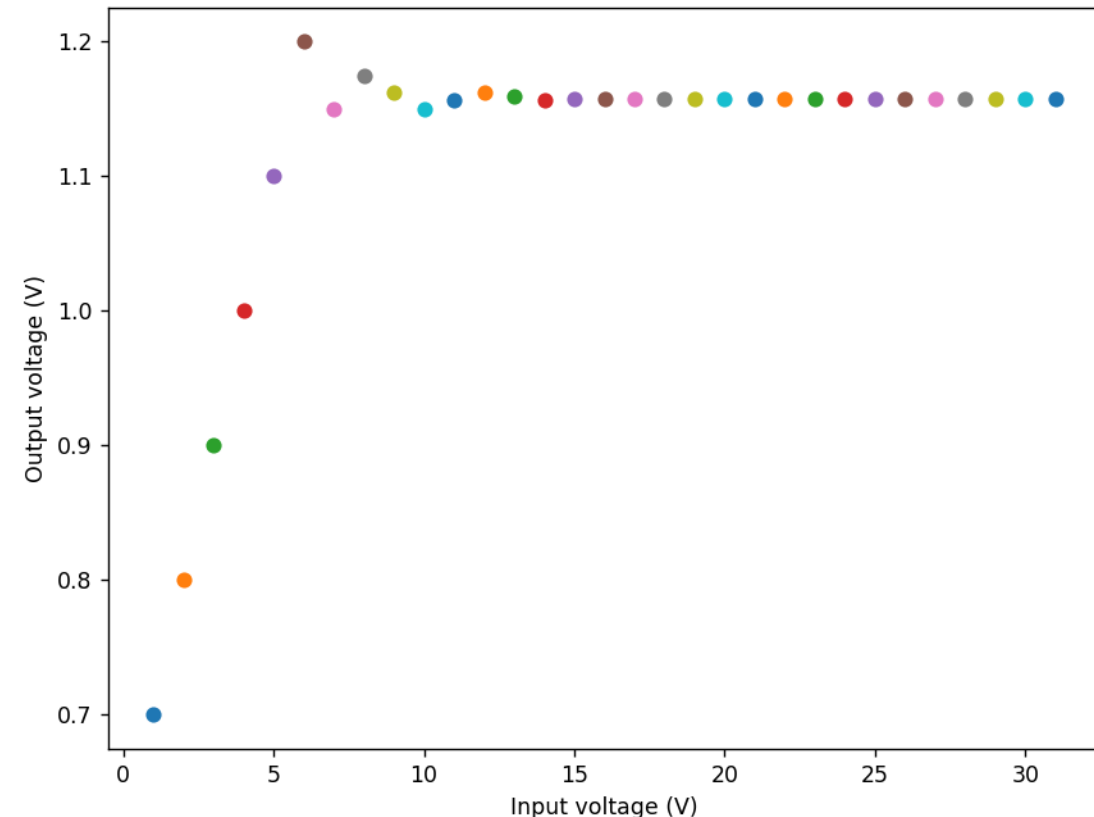
- Assume that $V_{DD} = 1.2$ V.
 - For example, at $V_{in} = 0.5$ V and $V_{out} = 0.7$ V, we have $I_{Dn} = 1.77$ μ A and $I_{Dp} = -7.92$ μ A. Certainly, it is not on the VTC.

One possible way (Trial-and-error)

- In order to increase I_{Dn} , we can try a higher V_{out} , for example 0.8 V.
 - Still, the currents are much different.
 - 0.9 V. No.
 - 1.0 V. No.
 - 1.1 V. No.
 - 1.2 V. Well, now, $I_{Dn} = 1.92 \mu\text{A}$ and $I_{Dp} = 0 \text{ A}$. We must increase $|I_{Dp}|$.
 - 1.15 V. $I_{Dn} = 1.91 \mu\text{A}$ and $I_{Dp} = -2.22 \mu\text{A}$. We must increase I_{Dn} .
 - 1.175 V. $I_{Dn} = 1.91 \mu\text{A}$ and $I_{Dp} = -1.16 \mu\text{A}$. We must increase $|I_{Dp}|$.
 - 1.1625 V. $I_{Dn} = 1.91 \mu\text{A}$ and $I_{Dp} = -1.70 \mu\text{A}$. We are getting closer...

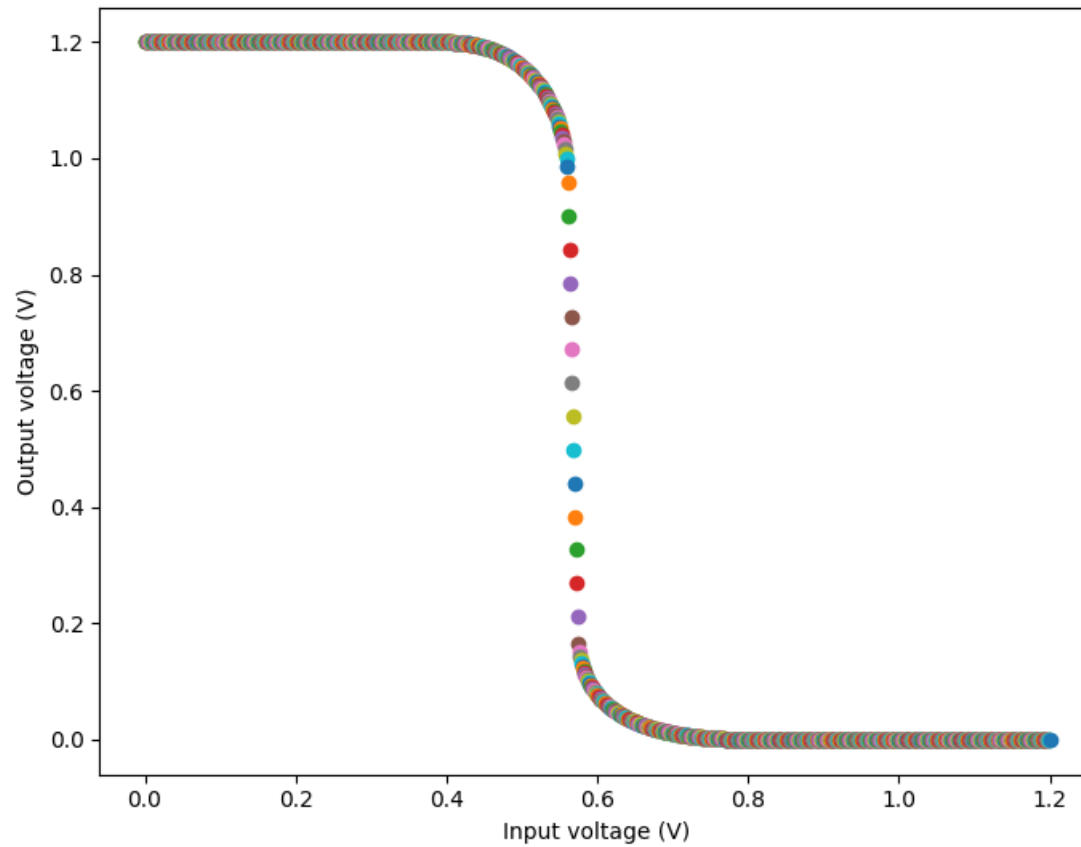
Number of iterations

- When we have a voltage change smaller than 1 μV , the calculation stops.
 - Start at $\frac{V_{DD}}{2}$.
 - Initial step is 0.1 V.
 - When the sign of difference changes, the step is reduced with a factor of 0.5. Otherwise, keep the step.
 - 31 iterations at $V_{in} = 0.5 \text{ V}$



Homework#2

- Due: AM08:00, September 19 (Two weeks later)
- Problem#1
 - Draw the voltage transfer curve.



Thank you for your attention!